TOSHIBA Photocoupler GaAs Ired & Photo-Transistor

# TLP629,TLP629-2,TLP629-4

#### Telecommunication Office Machine

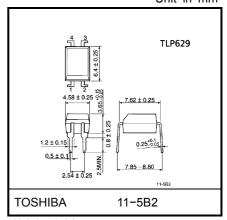
### **Telephone Use Equipment**

The TOSHIBA TLP629, -2, and -4 consists of a photo-transistor optically coupled to a gallium arsenide infrared emitting diode. The TLP629-2 offers two isolated channels in an eight lead plastic DIP, while the TLP629-4 provides four isolated channels in a sixteen plastic DIP. This is suitable for application of DC input current up to 150mA.

- IF maximum rating: 150mA •
- Collector-emitter voltage: 55V (min.) •
- Current transfer ratio: 25% (min.) (IF=20mA)
- Isolation voltage: 5000Vrms (min.) •

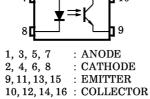
**Pin Configurations (top view)** 

UL recognized: UL1577, file no. E67349





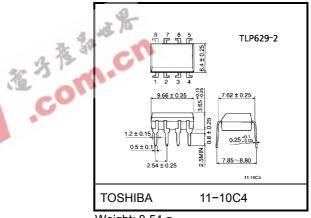
#### TLP629-4 **TLP629** TLP629-2 116 11 41 8 1 3 2 72 2 1 : ANODE 2 : CATHODE 3 16 3 : EMITTER 4 : COLLECTOR 1, 3 : ANODE 2, 4 : CATHODE 5 112 5, 7 : EMITTER 6, 8 : COLLECTOR 6 11 7 110



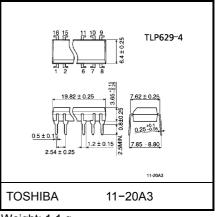
15

14

13



Weight: 0.54 g





#### Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Ra	Unit	
		Symbol	TLP629	TLP629–2,4	Offic
LED	Forward current	١ <sub>F</sub>	1	150	
	Forward current derating	ΔI <sub>F</sub> / °C	–1.5 (Ta	–1.5 (Ta ≥ 25°C)	
	Pulse forward current	I <sub>FP</sub>	1 (100µs pulse, 100pps)		А
	Reverse voltage	V <sub>R</sub>		V	
	Junction temperature	Тj	125		°C
	Collector-emitter voltage	V <sub>CEO</sub>	5	V	
	Emitter-collector valtage	V <sub>ECO</sub>		7	
ъ	Collector current	۱ <sub>C</sub>	80		mA
Detector	Collector power dissipation (1 circuit)	P <sub>C</sub>	150	100	mW
	Collector power dissipation derating (1 circuit, Ta ≥ 25°C)	ΔP <sub>C</sub> / °C	-1.5	-1.0	mW / °C
	Junction temperature	Тj	125		°C
Stor	age temperature range	T <sub>stg</sub>	-55~125		°C
Operating temperature range		T <sub>opr</sub>	-55~100		°C
Lead soldering temperature		T <sub>sol</sub>	260 (10s)		°C
Total package power dissipation		Ρ <sub>T</sub>	250	200	mW
	Total package power dissipation derating (Ta≥25°C)		-2.5	2.0	mW / °C
Isola	ation voltage (Note 1)	BVS	5000 (AC, 1m	in., RH ≤ 60%)	V <sub>rms</sub>

(Note 1) Device considered a two terminal: LED side pins shorted together, and detector side pins shorted together.

#### **Recommended Operating Conditions**

Characteristics	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V <sub>CC</sub>	_	5	24	V
Forward current	١ <sub>F</sub>	—	20	120	mA
Collector current	Ι <sub>C</sub>	—	1	10	mA
Operating temperature	T <sub>opr</sub>	-25		85	°C

### Individual Electrical Characteristics (Ta = 25°C)

	Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 100 mA	_	1.4	1.7	V
	Forward current	I <sub>F</sub>	V <sub>F</sub> = 0.7 V	_	2.5	20	μA
	Reverse current	I <sub>R</sub>	V <sub>R</sub> = 5 V	_	_	10	μA
	Capacitance	CT	V = 0, f = 1 MHz	_	50		pF
Detector	Collector–emitter breakdown voltage	V <sub>(BR)</sub> CEO	I <sub>C</sub> = 0.5 mA	55	_	_	V
	Emitter–collector breakdown voltage	V <sub>(BR) ECO</sub>	I <sub>E</sub> = 0.1 mA	7	_	_	V
	Collector dark current	1050	V <sub>CE</sub> = 24 V	_	10	100	nA
		ICEO	V <sub>CE</sub> = 24 V, Ta = 85°C	_	2	50	μA
	Capacitance collector to emitter	C <sub>CE</sub>	V = 0, f = 1 MHz	_	10	_	pF

#### **Coupled Electrical Characteristics (Ta = 25°C)**

Characteristic	Symbol	Test Condition	Mln.	Тур.	Max.	Unit	
Current transfer ratio	I <sub>C</sub> / I <sub>F</sub>	I <sub>F</sub> = 20 mA, V <sub>CE</sub> = 1 V	25	_	_		
	I <sub>C</sub> / I <sub>F</sub> (high)	I <sub>F</sub> = 100 mA, V <sub>CE</sub> = 1 V	20	_	80	%	
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	I <sub>C</sub> = 2.4 mA, I <sub>F</sub> = 20 mA		_	0.4	v	
		I <sub>C</sub> = 2.4 mA, I <sub>F</sub> = 100 mA	_	_	0.4		
Off-state collector current	I <sub>C(off)</sub>	V <sub>F</sub> = 0.7V, V <sub>CEO</sub> = 24 V	_	1	1.0	μA	
plation Characteristics (Ta = $25^{\circ}$ C)							

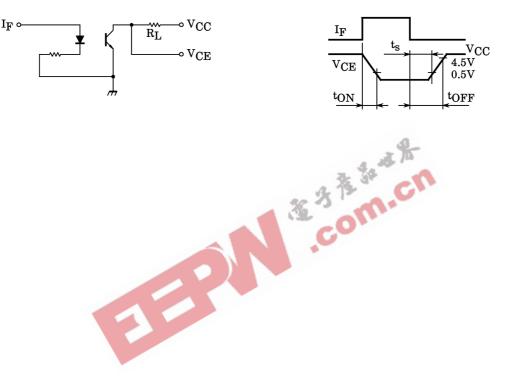
# Isolation Characteristics (Ta = 25°C)

Characteristic	~	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Capacitance input to output		CS	V <sub>S</sub> = 0, f = 1 MHz	_	0.8	_	pF
Isolation resistance		R <sub>S</sub>	V <sub>S</sub> = 500 V	5×10 <sup>10</sup>	10 <sup>14</sup>		Ω
			AC, 1 minute	5000		_	V
Isolation voltage			AC, 1 second, in oil	_	10000	_	V <sub>rms</sub>
			DC, 1 minute, in oil	—	10000		Vdc

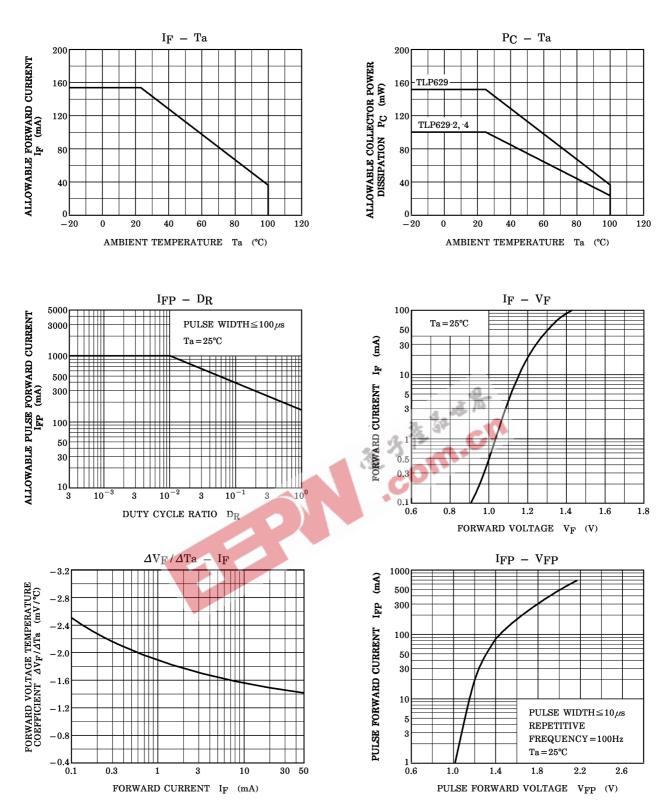
Switching Characteristics (Ta = 25°C)

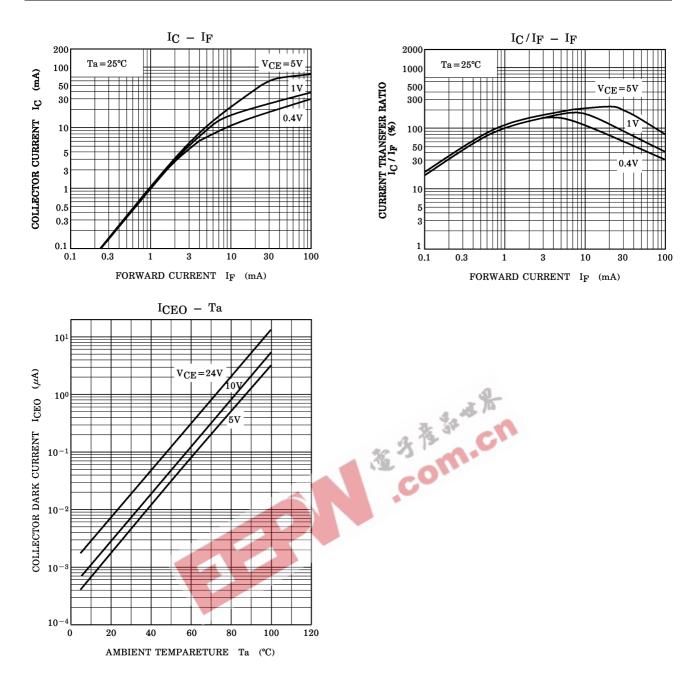
Characteristic	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Rise time	tr		_	2	—	
Fall time	t <sub>f</sub>	V <sub>CC</sub> = 10 V, I <sub>C</sub> = 2 mA	_	3	_	μs
Turn–on time	t <sub>on</sub>	R <sub>L</sub> = 100Ω	-	3	10	
Turn–off time	t <sub>off</sub>		_	3	10	
Turn–on time	t <sub>ON</sub>		_	2	_	
Storage time	ts	$R_L$ = 1.9 kΩ (Fig.1) V <sub>CC</sub> = 5 V, I <sub>F</sub> = 16 mA	_	15	_	μs
Turn-off time	t <sub>OFF</sub>		_	25	_	

Fig. 1 Switching time test circuit



## TOSHIBA







#### 000707EBC

#### **RESTRICTIONS ON PRODUCT USE**

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- Gallium arsenide (GaAs) is a substance used in the products described in this document. GaAs dust and fumes are toxic. Do not break, cut or pulverize the product, or use chemicals to dissolve them. When disposing of the products, follow the appropriate regulations. Do not dispose of the products with other industrial waste or with domestic garbage.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.

